

## SLVU2.8-8 EPD TVS™ Diode Array For ESD and Latch-Up Protection

## PROTECTION PRODUCTS

#### Description

The SLV series of transient voltage suppressors are designed to protect low voltage, state-of-the-art CMOS semiconductors from transients caused by electrostatic discharge (ESD), cable discharge events (CDE), lightning and other induced voltage surges.

The devices are constructed using Semtech's proprietary EPD process technology. The EPD process provides low standoff voltages with significant reductions in leakage currents and capacitance over siliconavalanche diode processes. The SLVU2.8-8 features integrated low capacitance compensation diodes that reduce the maximum capacitance to 8pF per line. This, combined with low leakage current, means signal integrity is preserved in high-speed applications such as 10/100/1000 Ethernet.

The SLVU2.8-8 is in an SO-8 package and may be used to protect four high-speed line pairs. The layout of the device minimizes trace inductance and reduces voltage overshoot associated with ESD events. The low clamping voltage of the SLVU2.8-8 minimizes the stress on the protected IC.

The SLV series TVS diodes will meet the surge requirements of IEC 61000-4-2 (ESD), IEC61000-4-5 (Lightning), and ETSI ETS 300 386.

Circuit Diagram (Each Line)

#### Features

- 600 Watts peak pulse power (tp =  $8/20\mu s$ )
- ◆ Transient protection for high speed data lines to IEC 61000-4-2 (ESD) 15kV (air), 8kV (contact) IEC 61000-4-4 (EFT) 40A (tp = 5/50ns) IEC 61000-4-5 (Lightning) 24A (tp = 8/20µs)
- Protects four line pairs (eight lines)
- Comprehensive pin out for easy board layout
- Low capacitance
- High peak pulse current (30A, 8/20μs)
- Low leakage current
- Low operating and clamping voltages
- Solid-state EPD TVS process technology

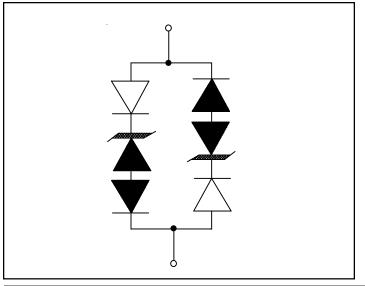
#### Mechanical Characteristics

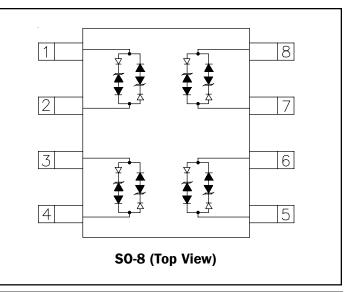
- ◆ JEDEC SO-8 package
- Molding compound flammability rating: UL 94V-0
- Marking : Part number, date code, logo
- Packaging : Tape and Reel per EIA 481

#### Applications

- ◆ 10/100/1000 Ethernet
- ◆ WAN/LAN Equipment
- Switching Systems
- DSLAMs
- Desktops, Servers, & Notebooks
- Instrumentation
- Base Stations
- Analog Inputs

### Schematic & PIN Configuration







## **PROTECTION PRODUCTS**

## Absolute Maximum Rating

Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20µs)	P <sub>pk</sub>	600	Watts
Peak Pulse Current (tp = 8/20µs)	I <sub>pp</sub>	30	A
ESD per IEC 61000-4-2 (Air) ESD per IEC 61000-4-2 (Contact)	V <sub>ESD</sub>	30 25	kV
Lead Soldering Temperature	T	240 (10 seconds)	°C
Operating Temperature	T,	-55 to +125	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C

## Electrical Characteristics (T=25°C)

SLVU2.8-8							
Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	
Reverse Stand-Off Voltage	V <sub>RWM</sub>				2.8	V	
Punch-Through Voltage	V <sub>PT</sub>	Ι <sub>ΡΤ</sub> = 2μΑ	3.0			V	
Snap-Back Voltage	V <sub>SB</sub>	I <sub>sb</sub> = 50mA	2.8			V	
Reverse Leakage Current	I <sub>R</sub>	V <sub>RWM</sub> = 2.8V, T=25°C (Each Line)		.100	1	μA	
Clamping Voltage	V <sub>c</sub>	I <sub>PP</sub> = 1A, tp = 8/20μs (Each Line)			4.6	V	
Clamping Voltage	V <sub>c</sub>	I <sub>PP</sub> = 24A, tp = 8/20µs (Each Line)			15	V	
Clamping Voltage	V <sub>c</sub>	I <sub>pp</sub> = 30A, tp = 8/20µs (Each Line)			17	V	
Maximum Peak Pulse Current	I <sub>PP</sub>	tp = 8/20µs			30	A	
Junction Capacitance	C <sub>j</sub>	V <sub>R</sub> = 0V, f = 1MHz (Each Line)			8	pF	

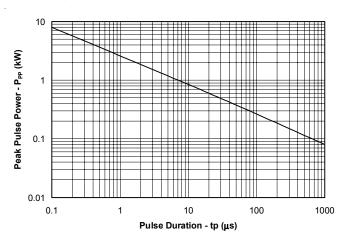
# SLVU2.8-8



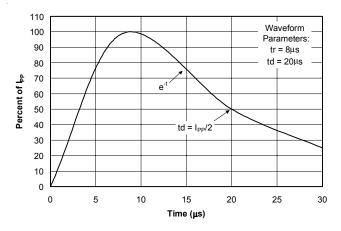
## PROTECTION PRODUCTS

#### **Typical Characteristics**

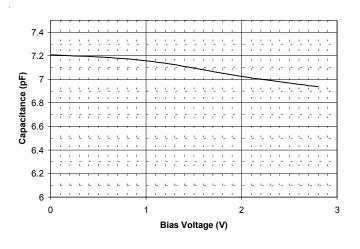
#### Non-Repetitive Peak Pulse Power vs. Pulse Time

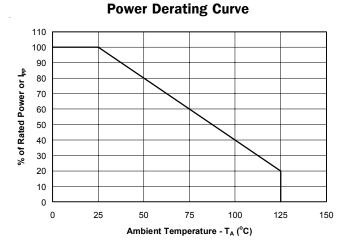


**Pulse Waveform** 

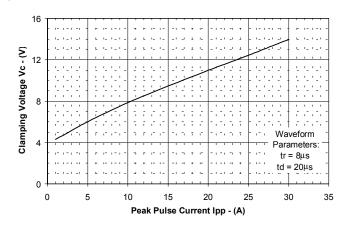


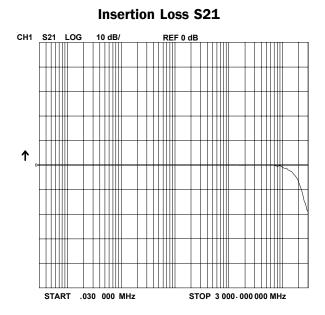
**Capacitance vs. Reverse Voltage** 





**Clamping Voltage vs. Peak Pulse Current** 





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# SLVU2.8-8



# PROTECTION PRODUCTS

### Applications Information

#### **Device Connection for Protection of Eight Data Lines**

Electronic equipment is susceptible to transient disturbances from a variety of sources including: ESD to an open connector or interface, direct or nearby lightning strikes to cables and wires, and charged cables "hot plugged" into I/O ports. The SLVU2.8-8 is designed to protect sensitive components from damage and latchup which may result from such transient events. The SLVU2.8-8 can be configured to protect four highspeed line pairs differentially, or four lines to ground (common mode). The device is connected as follows:

#### **1.** Differential Protection of four line pairs:

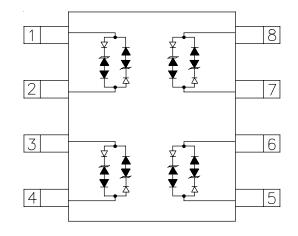
Line pairs are connected at pins 1 and 2, 3 and 4, 5 and 6, and 7 and 8.

# **Circuit Board Layout Recommendations for Suppression of ESD.**

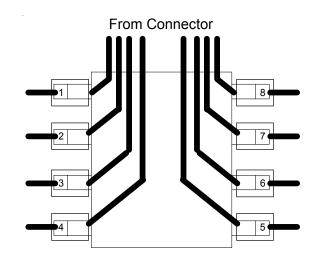
Good circuit board layout is critical for the suppression of ESD induced transients. The following guidelines are recommended:

- Place the device near the input terminals or connectors to restrict transient coupling.
- Minimize the path length between the TVS and the protected line.
- Minimize all conductive loops including power and ground loops.
- The ESD transient return path to ground should be kept as short as possible.
- Never run critical signals near board edges.
- Use ground planes whenever possible.

SLVU2.8-8 Circuit Diagram



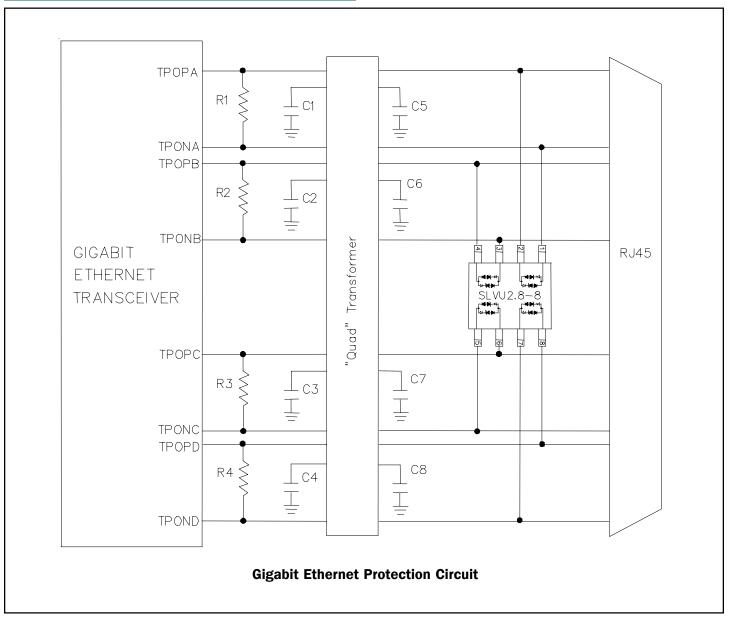
#### **Differential Protection of Four Line Pairs**





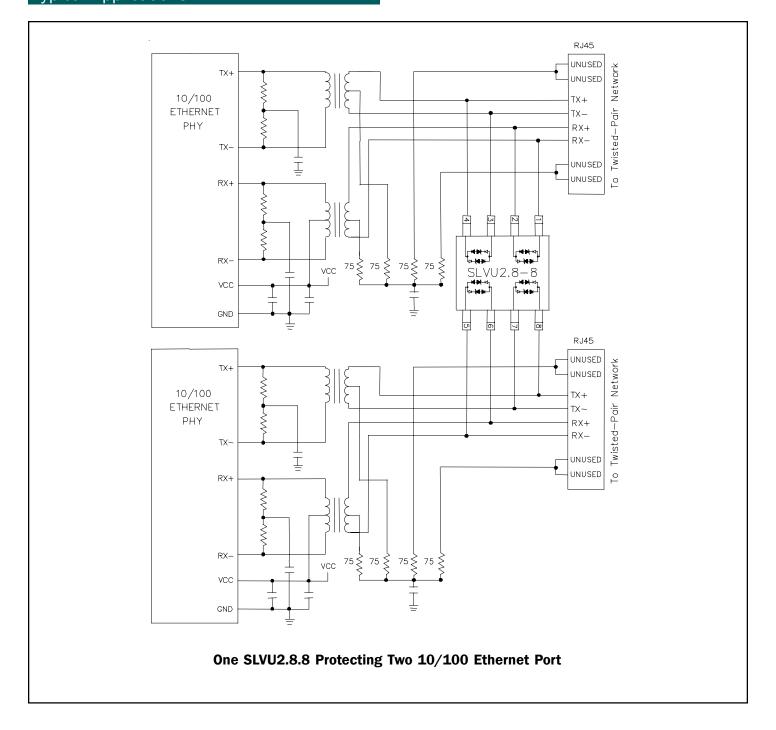
## PROTECTION PRODUCTS

## Typical Applications





# Typical Applications



# SLVU2.8-8



### **PROTECTION PRODUCTS**

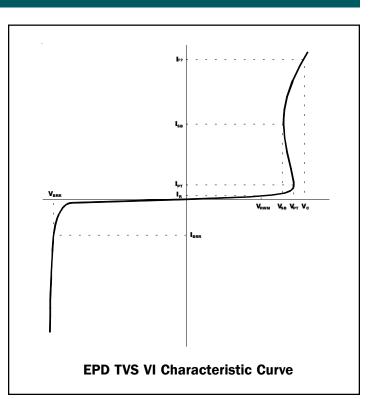
### Applications Information (continued)

#### **EPD TVS™ Characteristics**

The SLVU2.8-8 is constructed using Semtech's proprietary EPD technology. The structure of the EPD TVS is vastly different from the traditional pn-junction devices. At voltages below 5V, high leakage current and junction capacitance render conventional avalanche technology impractical for most applications. However, by utilizing the EPD technology, the SLVU2.8-8 can effectively operate at 2.8V while maintaining excellent electrical characteristics.

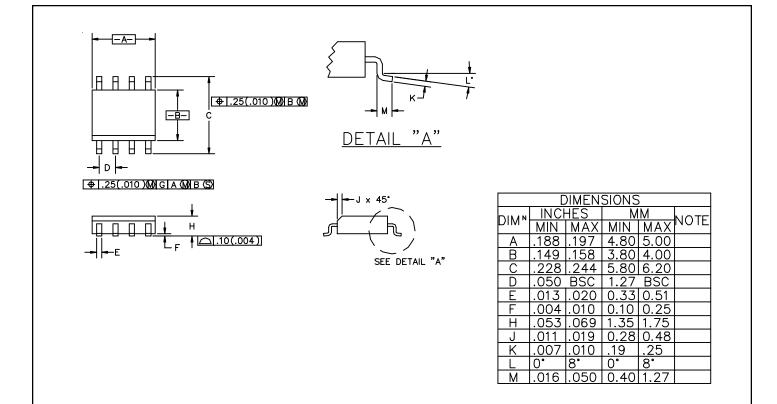
The EPD TVS employs a complex nppn structure in contrast to the pn structure normally found in traditional silicon-avalanche TVS diodes. The EPD mechanism is achieved by engineering the center region of the device such that the reverse biased junction does not avalanche, but will "punch-through" to a conducting state. This structure results in a device with superior dc electrical parameters at low voltages while maintaining the capability to absorb high transient currents.

The IV characteristic curve of the EPD device is shown in Figure 1. The device represents a high impedance to the circuit up to the working voltage ( $V_{RWM}$ ). During a transient event, the device will begin to conduct as it is biased in the reverse direction. When the punchthrough voltage ( $V_{PT}$ ) is exceeded, the device enters a low impedance state, diverting the transient current away from the protected circuit. When the device is conducting current, it will exhibit a slight "snap-back" or negative resistance characteristic due to its structure. This must be considered when connecting the device to a power supply rail. To return to a non-conducting state, the current through the device must fall below the snap-back current (approximately < 50mA).

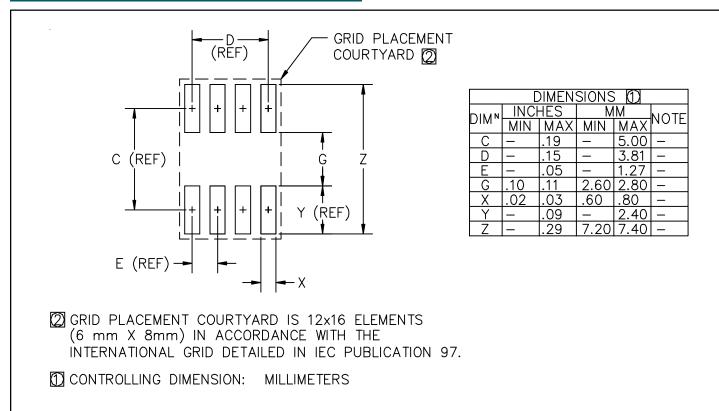




## **PROTECTION PRODUCTS** Outline Drawing - SO-8

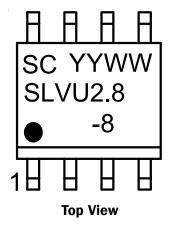


#### Land Pattern - SO-8





Marking



Note: (1) yyww = Date Code

## **Ordering Information**

Part Number	Working Voltage	Qty per Reel	Reel Size	
SLVU2.8-8.TB	2.8V	500	7 Inch	
SLVU2.8-8.TE	2.8V	2,500	13 Inch	

Note:

(1) No suffix indicates tube pack.

**Contact Information** 

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